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Pillai N., Vijayamohanan

Centre for Development Studies, Prasanth Nagar, Ulloor,
Trivandrum, Kerala, India

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Reliability Rate**

Vijayamohanan Pillai N.

**Associate Fellow
Centre for Development Studies
Trivandrum – 695 011
Kerala
India**

E-mail: vijayamohan@cds.ac.in

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Abstract

Reliability in its broad sense refers to the probability that a component or system is able to perform its intended function satisfactorily during a specified period of time under normal operating conditions. It is estimated as the fraction of time the unit/system is available for operation. For practical purposes, reliability rate is estimated using maximum likelihood estimator (MLE) from sample observations.. No study has gone beyond this to analyze the statistical properties of the MLE of R ; the present study is an attempt at such a quest.

In Quest of the Distributional Properties of Reliability Rate

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1. Introduction

Reliability in its broad sense refers to the probability that a component or system comprising components is able to perform its intended function satisfactorily during a specified period of time under normal operating conditions (see Bazovsky 1961). A simple representation of the life history of repairable electric power system component during the useful life period is by a two-state model, the possible states being labeled ‘up’ (functioning) and ‘down’ (unavailable). Thus, when the component fails it is said to undergo a transition from the up to the down state, and conversely, when repairs are over, it is said to return from the down to the up state. This idea then facilitates interpreting the concept of reliability in terms of the fraction of total time the component spends in the up-state.

Thus suppose that the mode of performance of a component of a system may be represented by a Bernoulli random variable, X_i , with values 1 and 0 according as the component is functioning or not functioning. Then $P_i = \Pr\{X_i = 1\} = 1 - \Pr\{X_i = 0\}$ is the reliability of the i th component.

Assume that a component functions for some time after which it fails and remains in that non-functioning state. The time duration, t , for which it functions is its life time. The number of failures per unit of time of the component is its hazard (failure) rate and the number of repairs per unit time is its repair rate.

Usually the failure and repair rates are assumed to be constant; this leads to the assumption that the time-to-failure and the time-to-repair variables follow exponential distribution. The exponential distribution is one of the two (the other being the geometric distribution) unique distributions with the memoryless or no-ageing property. That is, future lifetime of a component remains the same irrespective of its previous use, if its lifetime distribution is exponential.

Thus we assume that the time-to-failure, X , is an exponential variable with parameter ρ , so that its density function, *viz.*, failure (hazard) density function, $f(x)$, is given by $f(x) =$

$\frac{1}{\rho} \exp\left(\frac{-x}{\rho}\right)$, for $x > 0$. The parameter $1/\rho$ is the constant failure (hazard) rate. For an exponential distribution of the above form, the mean is given by ρ . Hence the mean-time-to-failure (MTTF) of the power plant is equal to ρ ; this is also known as the expected survival time. The probability of a plant surviving at time t in a constant failure rate environment, i.e., its survival function, denoted by $R(t)$, is then obtained by integrating the failure density function, $f(x)$, and is given by $R(t) = \exp(-x/\rho)$. The complement of this survival probability is the probability of failure in time t , given by $1 - \exp(-x/\rho)$.

Similarly we assume an exponential model with parameter ω for the time-to-repair variable Y , so that the density function of Y , viz., the repair density function, $g(y)$, is $g(y) = \frac{1}{\omega} \exp\left(\frac{-y}{\omega}\right)$, for $y > 0$. In this model, $1/\omega$ is the constant repair rate and its reciprocal, ω , is the mean down (repair) time (MDT) or the expected outage time. The sum of MTTF and MDT is termed the mean-time-between-failures (MTBF) or cycle time.

In the case of a power generating system, for example, its ability to meet the demand for power at any given time represents its reliability. One of the major determinants of the system reliability is the reliability of the power generating unit, as it relies on the frequency with which a unit is likely to fall out of service due to a forced outage. Forced outages occur when a unit is thrown out of service due to unexpected causes such as break down, equipment malfunction, etc., and are usually of a random nature. On the other hand, preventive maintenance is a planned one, intended to ensure the proper running conditions of the units. Generator deratings that follow equipment troubles and changes in operating conditions as well as the age of the equipment also lead to shortages.

The failure pattern of a given unit is usually described by its forced outage rate (denoted here by O), computed as a percentage of the unit's forced outage (down) time relative to the total service plus forced outage time. That is,

$$O = \text{Down Time} / (\text{Down Time} + \text{Service Time}),$$

It goes without saying that the complement of the outage rate (O) is the availability rate, representing the fraction of time the unit is available for operation; this then represents the reliability rate; i.e., reliability rate, $R = 1 - O$.

For practical purposes, reliability rate (or outage rate) is estimated using maximum likelihood estimator (MLE) from sample observations, as the parameters of the exponential models assumed for the time-to-failure (X) and the time-to-repair (Y) variables usually are unknown. No study has gone beyond this to analyze the statistical properties of the MLE of R ; the present study is an attempt at such a quest.

What follows is divided into three sections: the next section presents a detailed overview of the long-run and instantaneous reliability rates; section 3 discusses the MLE of R , and our quest for the statistical properties of the MLE of R constitutes part 4, followed by the concluding remarks.

2. The Long-Run and Instantaneous R s

The probabilistic approach to system reliability analysis views the system as a stochastic process evolving over time. At any moment the system may change from one state to another because of events such as component outages or planned maintenance. Corresponding to a pair of states, say (i, j) , there is a conditional probability of transition from the state i to the state j . The transition probabilities are defined with reference to the regularity postulate of Poisson process which states that for any $t > 0$, the probability of exactly one occurrence during the time interval $(t, t + h)$ is $\frac{1}{\rho}h + o(h)$, h being infinitesimally small, where the parameter ρ is independent of the state of the system at t which is characterized by the number of events that have occurred between 0 and t . Then the probability of no change occurring in $(t, t + h)$ is $1 - \frac{1}{\rho}h + o(h)$; and the probability of more than one occurrence is $o(h)$. $o(h)$ is used as a symbol to denote a function of h which tends to 0 more rapidly than h ; i.e.,

$$\text{as } h \rightarrow 0, o(h)/h = 0.$$

Also note that the interval times of a Poisson process with mean $\frac{1}{\rho}t$ are identically and independently distributed random variables (iid rvs) which follow the negative exponential law with mean ρ .

In a Markov process for a system, let the state space comprise two states, 'up' (operating) and 'down' (under repair (due to outage)), denoted by 1 and 0 respectively. We assume that the length of operating period (i.e., the time-to-failure, denoted by X) and that of the period under repair (i.e., the down-time, denoted by Y) are independent rvs having negative exponential distributions with means ρ (which we call mean time-to-failure, MTTF) and ω (mean down-time, MDT) respectively. The sum of MTTF and MDT is known as mean time-between-failure (MTBF) or cycle time. The parameter $1/\rho$ is the failure (hazard) rate and $1/\omega$, the repair rate.

Let $P_{ij}(h)$, $(i, j = 0, 1)$ be the probability of the transition of state from i to j in a small interval of time h . Then the four transition probabilities (Pillai, 1991, Ch. 4) are given by

$$\begin{aligned}
P_{01}(h) &= \Pr\{Z(t+h) = 1 \mid Z(t) = 0\} = \frac{1}{\omega} h + o(h) \\
P_{00}(h) &= \Pr\{Z(t+h) = 0 \mid Z(t) = 0\} = 1 - \frac{1}{\omega} h + o(h) \\
P_{10}(h) &= \Pr\{Z(t+h) = 0 \mid Z(t) = 1\} = \frac{1}{\rho} h + o(h) \\
P_{11}(h) &= \Pr\{Z(t+h) = 1 \mid Z(t) = 1\} = 1 - \frac{1}{\rho} h + o(h) \quad \dots\dots(1)
\end{aligned}$$

The Chapman – Kolmogorov forward equations for a time-homogeneous process is given by

$$P_{ij}(t+h) = \sum P_{ik}(t) P_{kj}(h), \quad (k = 0,1) \quad \dots\dots(2)$$

For different values of $i, j = 0,1$, we get four equations; for example, when $i, j = 0$,

$$\begin{aligned}
P_{00}(t+h) &= P_{00}(t) P_{00}(h) + P_{01}(t) P_{10}(h) \\
&= P_{00}(t) \left\{ 1 - \frac{1}{\omega} h + o(h) \right\} + P_{01}(t) \left\{ \frac{1}{\rho} h + o(h) \right\} \quad \dots\dots(3)
\end{aligned}$$

Taking the limit as $h \rightarrow 0$,

$$\frac{dP_{00}(t)}{dt} = -\frac{1}{\omega} P_{00}(t) + \frac{1}{\rho} P_{01}(t) \quad \dots\dots(4)$$

Since $\sum_j P_{ij} = 1 \quad \forall i$, we use $P_{00}(t) + P_{01}(t) = 1$, to get

$$\frac{dP_{00}(t)}{dt} + \left(\frac{1}{\rho} + \frac{1}{\omega} \right) P_{00}(t) = \frac{1}{\rho}. \quad \dots\dots(5)$$

The solution of this non-homogeneous differential equation subject to the initial condition $P_{00}(0) = 1$ gives the probability that the unit continues to remain in outage, i. e.,

$$\begin{aligned}
P_{00}(t) &= \frac{(1/\rho)}{(1/\rho) + (1/\omega)} + \frac{(1/\omega)}{(1/\rho) + (1/\omega)} \exp\left\{-\left(\frac{1}{\rho} + \frac{1}{\omega}\right)t\right\} \\
&= \frac{\omega}{\rho + \omega} + \frac{\rho}{\rho + \omega} \exp\left\{-\left(\frac{1}{\rho} + \frac{1}{\omega}\right)t\right\}. \quad \dots\dots(6)
\end{aligned}$$

Hence, the transition probability that the unit becomes available after repair due to forced outage is:

$$P_{01=1-P_{00}}(t) = \frac{\rho}{\rho + \omega} - \frac{\rho}{\rho + \omega} \exp\left\{-\left(\frac{1}{\rho} + \frac{1}{\omega}\right)t\right\} \quad \dots\dots(7)$$

Similarly, the solution of the other differential equation, when $i, j = 1$, with the initial condition $P_{11} = 1$ gives the probability that the unit continues to remain in operating state, i. e.,

$$P_{11}(t) = \frac{\rho}{\rho + \omega} + \frac{\omega}{\rho + \omega} \exp\left\{-\left(\frac{1}{\rho} + \frac{1}{\omega}\right)t\right\} \quad \dots\dots(8)$$

and hence the transition probability that the unit falls into outage state from the operating state is:

$$P_{10}(t) = 1 - P_{11}(t) = \frac{\omega}{\rho + \omega} - \frac{\omega}{\rho + \omega} \exp\left\{-\left(\frac{1}{\rho} + \frac{1}{\omega}\right)t\right\} \quad \dots\dots(9)$$

When $t \rightarrow \infty$, these probabilities are known as limiting state probabilities that give the steady-state (or stationary or long-run) probabilities:

$$\lim_{t \rightarrow \infty} P_{00}(t) = \lim_{t \rightarrow \infty} P_{10}(t) = \omega/(\rho + \omega) \quad \dots\dots(10)$$

and

$$\lim_{t \rightarrow \infty} P_{11}(t) = \lim_{t \rightarrow \infty} P_{01}(t) = \rho/(\rho + \omega). \quad \dots\dots(11)$$

$$\text{Now } P_{00}(\infty) = P_{10}(\infty) = O = \frac{\omega}{\rho + \omega} = \frac{\text{MDT}}{\text{MTTF} + \text{MDT}} \quad \dots\dots(12)$$

gives the forced outage rate (O) as defined earlier, and

$$P_{11}(\infty) = P_{01}(\infty) = R = \frac{\rho}{\rho + \omega} = \frac{\text{MTTF}}{\text{MTTF} + \text{MDT}} = 1 - O \dots\dots(13)$$

is the reliability rate.

Note that the limiting distributions are independent of the initial state.

Equations (7) and (8) as such gives the 'instantaneous' measures (i. e., at time t) of R , denoted by $R_{11}(t)$ and $R_{01}(t)$ respectively, and (6) and (9), those outage rate, $O_{00}(t)$ and $O_{10}(t)$ respectively. Note the distinction between the instantaneous measures of the same rate.

3. Maximum Likelihood Estimation of R

In practice, the parameters of the exponential models assumed for the time-to-failure (X) and the time-to-repair (Y) variables usually are unknown, and so is the R . Hence the need to estimate it from sample observations.

Note that the R is determined by ρ and ω , the parameters of the models for X and Y . Therefore we can use the result of Zehna (1966) to find the maximum likelihood estimators (MLE) of the R by substituting the MLE of these parameters into (12) (and 13)). These estimators are obtained from a sample of n observations on X and Y .

The maximum likelihood procedure (Kendall and Stuart, 1963, Chapter 18) yields the following estimators:

the MLE of MTTF (ρ) = $\sum x_i / n = \bar{X}$, and

the MLE of MDT (ω) = $\sum y_i / n = \bar{Y}$.

Thus the MLE of $R = \frac{\sum x_i}{\sum x_i + \sum y_i}$(14)

Similarly, the MLE of outage rate, O , and those of the instantaneous rates, $O_{00}(t)$, $O_{10}(t)$, $R_{11}(t)$, and $R_{01}(t)$ as well as of the expected durations, may also be obtained.

4. Distributional Properties of R

In this section, we analyze the statistical properties of the MLE of R given by (14).

Since the n sample observations on X (the time-to-failure, or survival time) and Y (the time-to-repair or outage time) are drawn from two independent exponential populations with parameters ρ and ω respectively, it follows that

$$U = \frac{2\sum X_i}{\rho} \text{ and } V = \frac{2\sum Y_i}{\omega} \quad \dots\dots(15)$$

are two independent chi-square variables with $2n$ degrees of freedom (df). Remember that the moment generating function (mgf) of the χ^2 distribution with n degrees of freedom is given by $(1-2t)^{-n/2}$; we can find that the mgf of U (and of V) is $(1-2t)^{-n}$.

The MLE of R can now be rewritten in terms of these two variables as

$$R = \frac{\rho U}{\rho U + \omega V} \quad \dots\dots(16)$$

Given that the density function of a χ^2 variate is given by

$$\frac{1}{2^{n/2} \Gamma(n/2)} \left(\chi^2\right)^{\frac{n}{2}-1} \exp\left(-\frac{1}{2} \chi^2\right), \quad \chi^2 > 0,$$

we find the joint density of these two independent chi-square variables as

$$\frac{1}{2^{2n} (\Gamma n)^2} U^{n-1} V^{n-1} \exp\left(-\frac{1}{2}(U+V)\right), \quad U, V > 0. \quad \dots\dots(17)$$

Now using the transformation technique and (16), which gives $\left|\frac{\partial U}{\partial R}\right| = \frac{1}{(1-R)^2} \frac{\omega}{\rho} V$,

(V is taken here as a constant; in (16) V or U does not affect each other thru R .) we get the joint density of R and V :

$$\frac{1}{2^{2n} (\Gamma n)^2} \left(\frac{\omega}{\rho}\right)^n R^{n-1} (1-R)^{-n-1} V^{2n-1} \exp\left\{-\frac{1}{2}\left(1 + \frac{R}{1-R} \frac{\omega}{\rho}\right)V\right\},$$

$$0 < R < 1; \quad V > 0. \quad \dots\dots(18)$$

If we now integrate out the ‘extra’ variable V , we obtain the marginal density for R as:

$$f(R) = \frac{\Gamma(2n)}{(\Gamma n)^2} \left(\frac{\omega}{\rho}\right)^n R^{n-1} (1-R)^{n-1} \left[1 - \left(\frac{\rho - \omega}{\rho}\right)R\right]^{-2n}, 0 < R < 1. \dots\dots(19)$$

Similarly, it is easy to derive the marginal density element of the outage factor, O , as

$$g(O) = \frac{\Gamma(2n)}{(\Gamma n)^2} \left(\frac{\rho}{\omega}\right)^n O^{n-1} (1-O)^{n-1} \left[1 - \left(\frac{\omega - \rho}{\omega}\right)O\right]^{-2n}, 0 < O < 1. \dots\dots(19 a)$$

It goes without saying that the two are equal, since $O = (1 - R)$.

Now, given the density function of R , we can find its s^{th} raw moment as

$$\begin{aligned} E[R^S] &= \int_0^1 R^S f(R) dR \\ &= \frac{\Gamma(2n)}{(\Gamma n)^2} \left(\frac{\omega}{\rho}\right)^n \int_0^1 R^{n+s-1} (1-R)^{n-1} \left[1 - \left(\frac{\rho - \omega}{\rho}\right)R\right]^{-2n} dR. \dots\dots(20) \end{aligned}$$

The result of this is obtained with the help of *Euler's integral representation of the Gauss hyper-geometric series*:

$$\begin{aligned} H(a, b; c; z) &= \frac{\Gamma(c)}{\Gamma(b)\Gamma(c-b)} \int_0^1 t^{b-1} (1-t)^{c-b-1} (1-Zt)^{-a} dt \\ &= \sum_{k=0}^{\infty} \frac{(a)_k (b)_k}{(c)_k} \frac{Z^k}{k!}, \quad \Re_c > \Re_b > 0. \dots\dots(21) \end{aligned}$$

where Pochhammer's symbol

$$(a)_k = a (a+1) (a+2) \dots (a+k-1); \quad (a)_0 = 1.$$

Now comparing (20) and (21), we have

$$a = 2n, \quad b = n + s, \quad c - b = n, \quad \text{and} \quad c = 2n + s; \text{ and}$$

$$E[R^s] = \frac{\Gamma(2n)}{\Gamma(n)} \frac{\Gamma(n+s)}{\Gamma(2n+s)} \left(\frac{\omega}{\rho}\right)^n \sum_{k=0}^{\infty} \frac{(2n)_k (n+s)_k}{(2n+s)_k} \frac{\left(\frac{\rho-\omega}{\rho}\right)^k}{k!} \dots\dots(22)$$

Putting $s = 1$ and 2 in (22) yields the first two raw moments and thence the mean and variance of R :

$$E[R] = n \left(\frac{\omega}{\rho}\right)^n \sum_{k=0}^{\infty} \frac{(n+1)_k}{(2n+k)} \frac{\left(\frac{\rho-\omega}{\rho}\right)^k}{k!}; \quad \text{and} \quad \dots\dots(23)$$

$$Var[R] = n(n+1) \left(\frac{\omega}{\rho}\right)^n \sum_{k=0}^{\infty} \frac{(n+2)_k}{(2n+k+1)(2n+k)} \frac{\left(\frac{\rho-\omega}{\rho}\right)^k}{k!} - (E[R])^2. \quad \dots\dots(24)$$

It is however very difficult to evaluate these two moments as the series converge very slowly unless ρ and ω are nearly equal, a rare situation in general. This in turn precludes us from applying direct analytic methods to study the distributional characteristics of the reliability rate; an alternative here might be simulation methods, which I am trying at present.

5. CONCLUSION

This paper has purported to model the maximum likelihood estimation of reliability rate and the related statistical properties. Some of the empirical expositions of the reliability analysis presented here have already been done in my earlier papers, while this paper serves as a theoretical background. The major conclusion here is that the expression we have derived for analyzing the distributional properties of the reliability rate is less amenable to empirical estimation and thus remains only as an intellectual exercise. We feel that simulation might be a better alternative to direct analytic methods to study the distributional characteristics of the reliability rate.

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